


<b>Search Notes</b> 	<b>Application/Control No.</b> 10537473	<b>Applicant(s)/Patent Under Reexamination</b> BUECHLER ET AL.
	<b>Examiner</b> Barker, Matthew	<b>Art Unit</b> 3662

SEARCHED			
Class	Subclass	Date	Examiner
342	70-72	7/17/2007	Hien Ly
342	201,203,159,128,132	7/18/2007	Hien Ly
342	52	6/20/2008	MMB
	updated 342/52	1/13/2009	MMB

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor's name search	7/17/2007	Hien Ly
Plus search	7/17/2007	Hien Ly
NPL search	7/17/2007	Hien Ly
Text search	7/17/2007	Hien Ly
text Search (update)	12/27/2007	Hien Ly
NPL Search (update)	12/27/2007	Hien Ly
342/57, 58, 60, 70-72 text search - see printout	6/20/2008	MMB
New EAST text search - see printout	6/21/2008	MMB
IEEE search - see printout	6/21/2008	MMB
Updated text search	1/13/2009	MMB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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